



Sheet 1 of 1

FORM PTO-1449	U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE	ATTORNEY DOCKET NO. 1391.1056	APPLICATION NO. 10/786,083
INFORMATION DISCLOSURE STATEMENT <i>(Use several sheets if necessary)</i>		FIRST NAMED INVENTOR Ching Y. Suen et al.	
		FILING DATE February 26, 2004	GROUP PART UNIT 2624

U.S. PATENT DOCUMENTS

*EXAMINER INITIAL	DOCUMENT NO.	DATE	NAME	CLASS	SUB- CLASS	FILING DATE
	AA					
	AB					
	AC					
	AD					
	AE					
	AF					

FOREIGN PATENT DOCUMENTS

DOCUMENT NO.	DATE	COUNTRY	TRANSLATION YES NO	ABSTRACT
/GD/ AG 2002-140706	05/17/2002	Japan	X	
/GD/ AH 1-250184	10/05/1989	Japan		X Yes

OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, Etc.)

OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, Etc.)				TRANSLATION	
				YES	NO
/GD/	AM	Hiroshi Murase, "Parametric Eigenspace Method for Image Recognition", TECHNICAL SURVEY, 2002, Vol. 85, No. 4, pp. 252-258.			X

EXAMINER /Gregory Desire/	DATE CONSIDERED 02/08/2008
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*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.



ATTACHMENT 1(g)

LIST OF ADDITIONAL SUBMITTED DOCUMENTS	ATTORNEY DOCKET NO.	APPLICATION NO.
	1391.1056	10/786,083
	FIRST NAMED INVENTOR	
	Ching Y. Suen et al.	
	FILING DATE	GROUP ART UNIT
	February 26, 2004	2624

The following document(s) is/are listed in accordance with the duty of disclosure provisions of 37 CFR § 1.56, so that the Examiner may consider same should he deem any thereof to be material to examination of the subject application.

It is requested that the Examiner acknowledge his consideration of document(s) below-listed by initialing same in the space provided adjacent each such application and that the Examiner sign and date this form at the bottom thereof to confirm such consideration having been given.

This submission in no way represents an admission that any of the information listed herein constitutes prior art with respect to the subject application; and unless and until such prior art status is established, this submission is not a request that the information presented herein be printed on the face of any patent issuing from the subject application in which this information is being filed.

U.S. PATENT DOCUMENTS

*EXAMINER INITIAL		DOCUMENT NO.	DATE	NAME	CLASS	SUB- CLASS	FILING DATE
	AA						
	AB						

FOREIGN PATENT DOCUMENTS

		DOCUMENT NO.	DATE	COUNTRY	CLASS	SUB- CLASS	TRANSLATION YES NO	
	AC							
	AD							

OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, Etc.)

						TRANSLATION YES NO	
/GD/	AE	Japanese Patent Office Action, mailed July 31, 2007 and issued in corresponding Japanese Patent Application No. 2003-313367					X

EXAMINER	/Gregory Desire/	DATE CONSIDERED	02/08/2008
<p>*EXAMINER: Initial if document considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.</p>			